Search Notes		

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/722,257	TAO ET AL.	
Examiner	Art Unit	
Jason M. Nolan, Ph.D.	1626	

	SEAR	CHED	
Class	Subclass	Date	Examiner
548	469	6/21/2006	JMN

INT	ERFERENC	FERENCE SEARCHED	
Class	Subclass	Date	Examiner
548	469	6/22/2006	JMN
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
STN CASREACT Method search, printout attached	6/21/2006	NML
Inventor Search, reviewed for double patenting	6/20/2006	JMN
Abstract, Oath, Spec reviewed	6/21/2006	JMN
IDS Considered	6/21/2006	JMN
East Interference Search, printout attached	6/22/2006	JMN